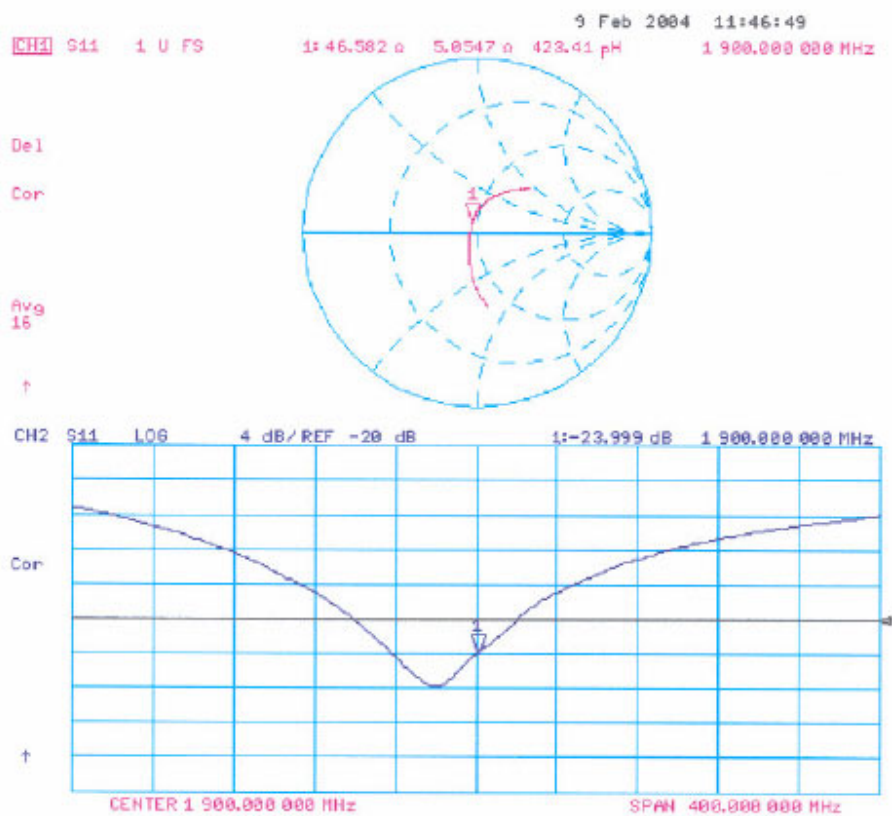




# FCC SAR Test Report

Test Report No : FA5N0707-1-2-01





**Calibration Laboratory of  
Schmid & Partner  
Engineering AG**  
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Multilateral Agreement for the recognition of calibration certificates**

Accreditation No.: **SCS 108**

Client **Sporton (Auden)**

Certificate No: **ET3-1788\_Sep04**

## CALIBRATION CERTIFICATE

Object **ET3DV6 - SN:1788**

Calibration procedure(s) **QA CAL-01.v5  
Calibration procedure for dosimetric E-field probes**

Calibration date: **September 30, 2004**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature  $(22 \pm 3)^{\circ}\text{C}$  and humidity  $< 70\%$ .

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	5-May-04 (METAS, No. 251-00388)	May-05
Power sensor E4412A	MY41495277	5-May-04 (METAS, No. 251-00388)	May-05
Reference 3 dB Attenuator	SN: S5054 (3c)	3-Apr-03 (METAS, No. 251-00403)	Aug-05
Reference 20 dB Attenuator	SN: S5086 (20b)	3-May-04 (METAS, No. 251-00389)	May-05
Reference 30 dB Attenuator	SN: S5129 (30b)	3-Apr-03 (METAS, No. 251-00404)	Aug-05
Reference Probe ES3DV2	SN:3013	8-Jan-04 (SPEAG, No. ES3-3013_Jan04)	Jan-05
DAE4	SN: 617	26-May-04 (SPEAG, No. DAE4-617_May04)	May-05

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092180	18-Sep-02 (SPEAG, in house check Oct-03)	In house check: Oct 05
RF generator HP 8648C	US3642U01700	4-Aug-99 (SPEAG, in house check Dec-03)	In house check: Dec-05
Network Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Nov-03)	In house check: Nov 04

	Name	Function	Signature
Calibrated by:	Nico Vetterli	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: October 1, 2004

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## Glossary:

TSL	tissue simulating liquid
NORM <sub>x,y,z</sub>	sensitivity in free space
ConF	sensitivity in TSL / NORM <sub>x,y,z</sub>
DCP	diode compression point
Polarization $\varphi$	$\varphi$ rotation around probe axis
Polarization $\vartheta$	$\vartheta$ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

## Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- CENELEC EN 50361, "Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones (300 MHz - 3 GHz), July 2001

## Methods Applied and Interpretation of Parameters:

- NORM<sub>x,y,z</sub>**: Assessed for E-field polarization  $\vartheta = 0$  ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide). NORM<sub>x,y,z</sub> are only intermediate values, i.e., the uncertainties of NORM<sub>x,y,z</sub> does not effect the E<sup>2</sup>-field uncertainty inside TSL (see below *ConvF*).
- NORM(f)<sub>x,y,z</sub> = NORM<sub>x,y,z</sub> \* frequency\_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- DCP<sub>x,y,z</sub>**: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for  $f \leq 800$  MHz) and inside waveguide using analytical field distributions based on power measurements for  $f > 800$  MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM<sub>x,y,z</sub> \* *ConvF* whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DASY 4.3 B17 and higher which allows extending the validity from  $\pm 50$  MHz to  $\pm 100$  MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.



ET3DV6 SN:1788

September 30, 2004

# Probe ET3DV6

## SN:1788

Manufactured:	May 28, 2003
Last calibrated:	August 29, 2003
Recalibrated:	September 30, 2004

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)





ET3DV6 SN:1788

September 30, 2004

**DASY - Parameters of Probe: ET3DV6 SN:1788****Sensitivity in Free Space<sup>A</sup>****Diode Compression<sup>B</sup>**

NormX	1.68 ± 9.9%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP X	94 mV
NormY	1.70 ± 9.9%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP Y	94 mV
NormZ	1.74 ± 9.9%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP Z	94 mV

**Sensitivity in Tissue Simulating Liquid (Conversion Factors)**

Please see Page 8.

**Boundary Effect****TSL                      900 MHz      Typical SAR gradient: 5 % per mm**

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR <sub>be</sub> [%]	Without Correction Algorithm	8.1	4.4
SAR <sub>be</sub> [%]	With Correction Algorithm	0.7	0.1

**TSL                      1810 MHz      Typical SAR gradient: 10 % per mm**

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR <sub>be</sub> [%]	Without Correction Algorithm	12.0	8.2
SAR <sub>be</sub> [%]	With Correction Algorithm	0.9	0.1

**Sensor Offset**Probe Tip to Sensor Center                      **2.7 mm**

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>A</sup> The uncertainties of NormX,Y,Z do not affect the E<sup>2</sup>-field uncertainty inside TSL (see Page 8).<sup>B</sup> Numerical linearization parameter: uncertainty not required.

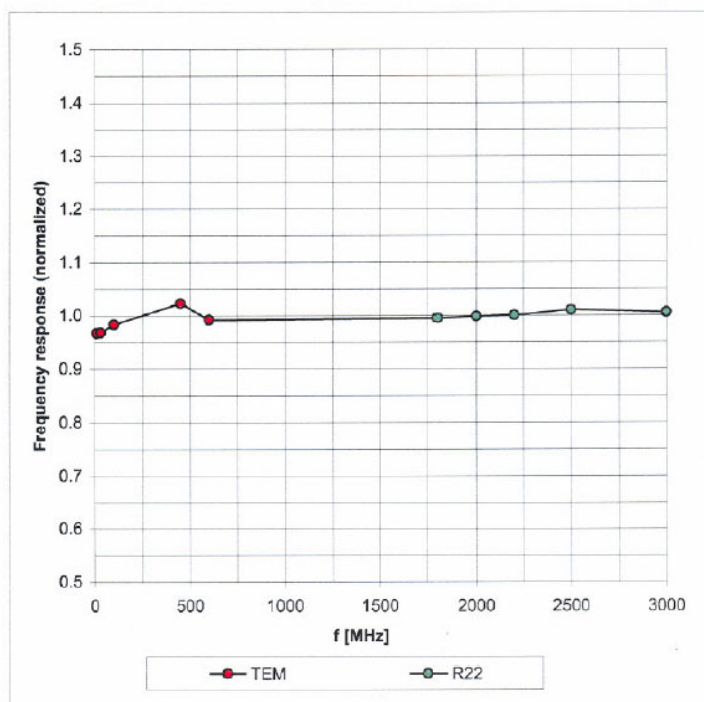


ET3DV6 SN:1788

September 30, 2004

## Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



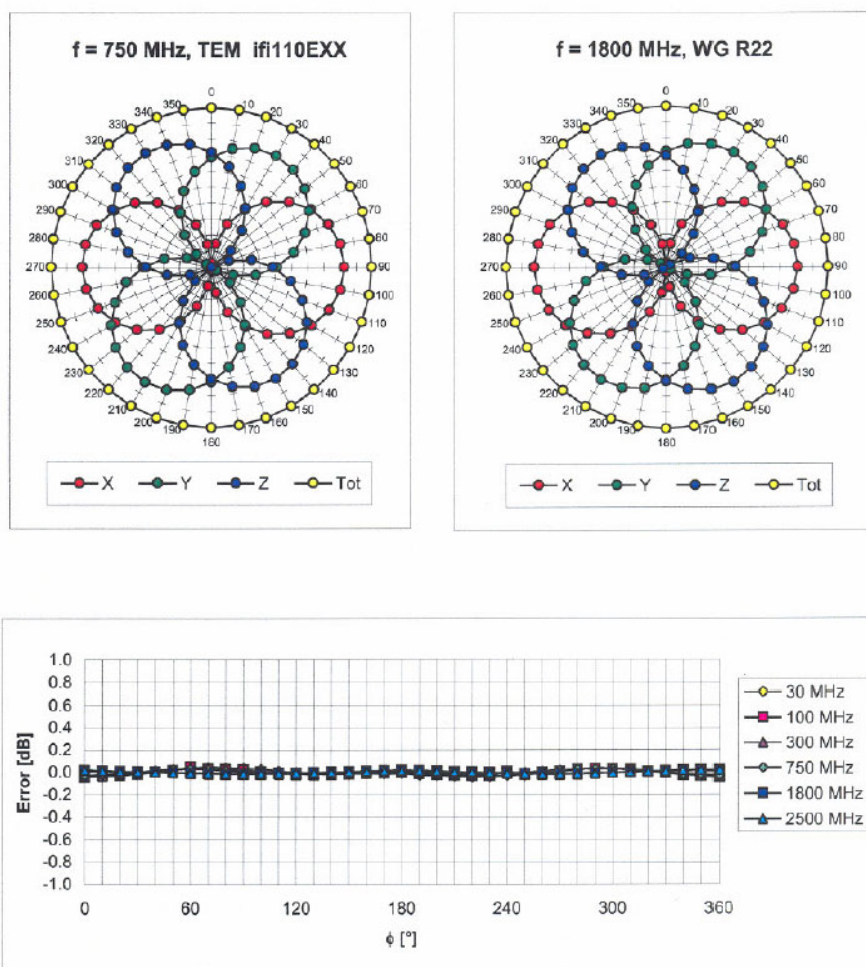
Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  (k=2)



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September 30, 2004

### Receiving Pattern ( $\phi$ ), $\theta = 0^\circ$



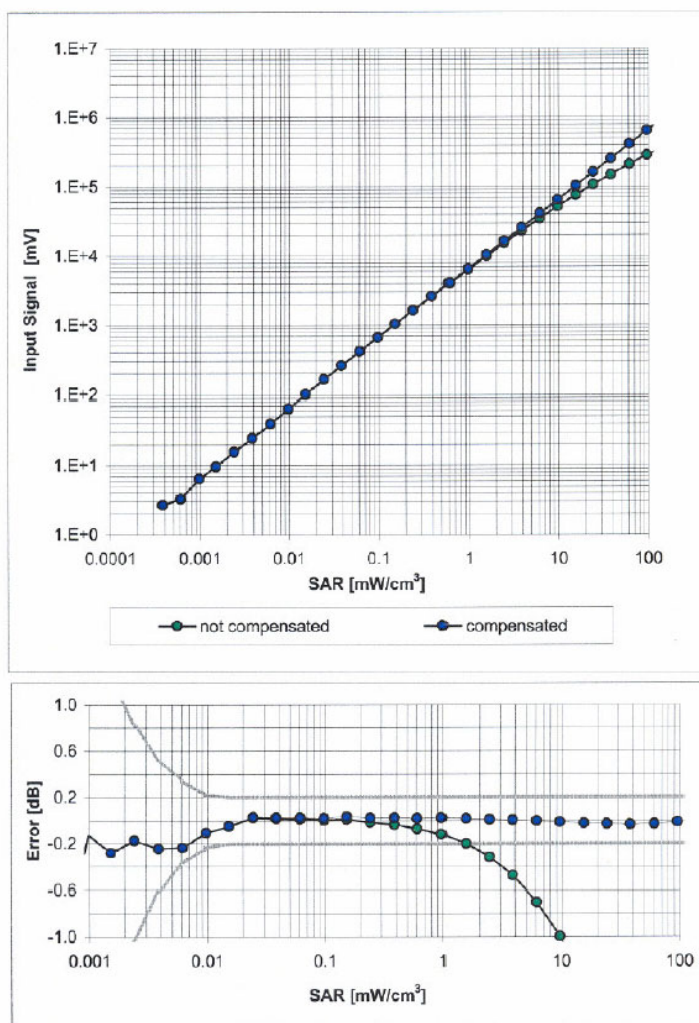
Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )



ET3DV6 SN:1788

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**Dynamic Range  $f(\text{SAR}_{\text{head}})$**   
(Waveguide R22,  $f = 1800$  MHz)



Uncertainty of Linearity Assessment:  $\pm 0.6\%$  ( $k=2$ )

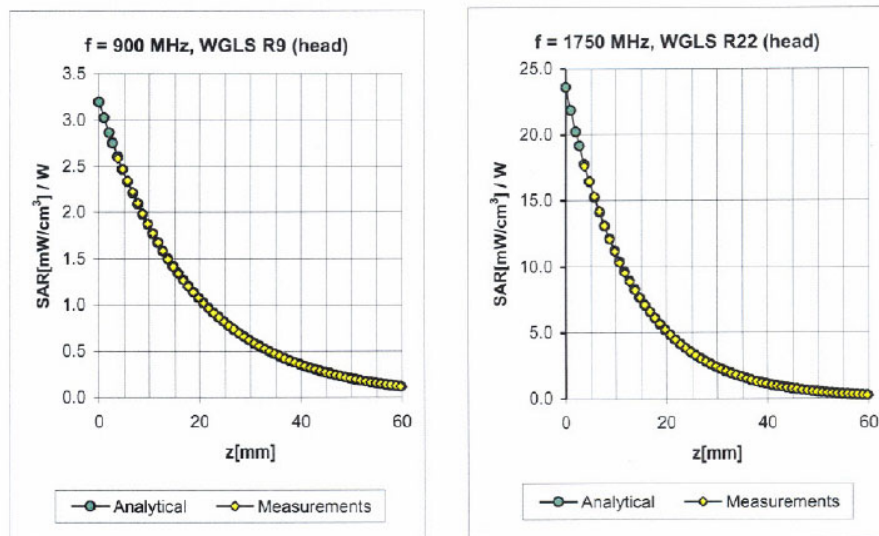




ET3DV6 SN:1788

September 30, 2004

## Conversion Factor Assessment



f [MHz]	Validity [MHz] <sup>c</sup>	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	1.12	1.42	6.74 ± 11.0% (k=2)
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	1.07	1.44	6.63 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.56	2.31	5.37 ± 11.0% (k=2)
1900	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.55	2.42	5.16 ± 11.0% (k=2)
2000	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.54	2.59	4.88 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.65	2.22	4.56 ± 11.8% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	1.04	1.52	6.53 ± 11.0% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.99	1.56	6.17 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.53	2.74	4.73 ± 11.0% (k=2)
1900	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.55	2.82	4.56 ± 11.0% (k=2)
2000	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.54	2.98	4.43 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.72	2.00	4.26 ± 11.8% (k=2)

<sup>c</sup> The validity of ± 100 MHz only applies for DASY 4.3 B17 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

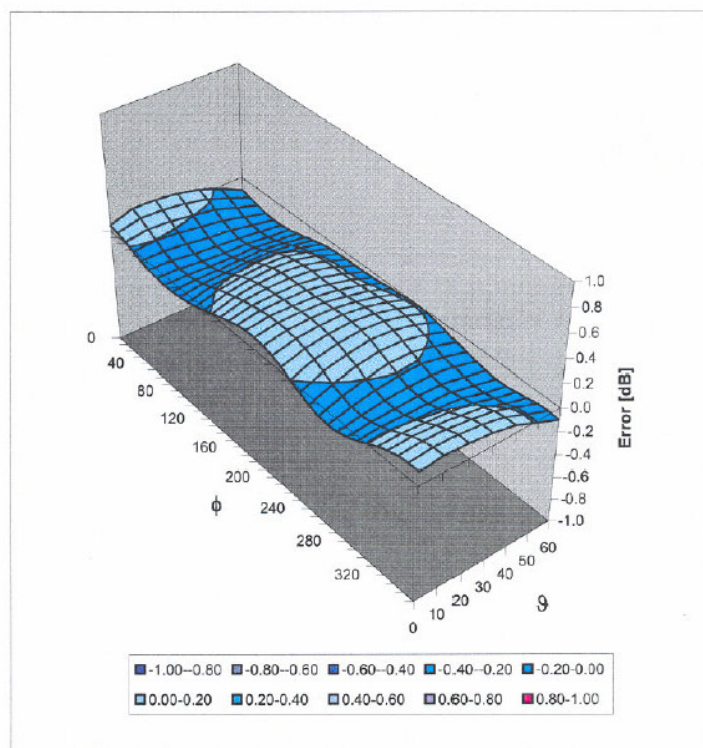


ET3DV6 SN:1788

September 30, 2004

### Deviation from Isotropy in HSL

Error ( $\phi$ ,  $\theta$ ),  $f = 900$  MHz



Uncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  ( $k=2$ )



## FCC SAR Test Report

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Accreditation No.: **SCS 108**

Client

Certificate No: **DAE4-658\_Mar05**

### CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BA - SN: 658**

Calibration procedure(s) **QA CAL-06.v10**  
**Calibration procedure for the data acquisition unit (DAE)**

Calibration date: **March 30, 2005**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature  $(22 \pm 3)^{\circ}\text{C}$  and humidity  $< 70\%$ .

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	7-Sep-04 (Sintrel, No.E-040073)	Sep-05
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1002	16-Jul-04 (SPEAG, in house check)	In house check Jul-05

Calibrated by:	Name	Function	Signature
	Eric Hainfeld	Technician	
Approved by:	Name	Function	Signature
	Fin Bornholt	R&D Director	

Issued: March 30, 2005

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Certificate No: DAE4-658\_Mar05

Page 1 of 5



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## Glossary

**DAE** digital acquisition electronics  
**Connector angle** information used in DASY system to align probe sensor X to the robot coordinate system.

## Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters contain technical information as a result from the performance test and require no uncertainty.
- **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
- **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
- **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
- **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
- **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
- **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
- **Input resistance:** DAE input resistance at the connector, during internal auto-zeroing and during measurement.
- **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
- **Power consumption:** Typical value for information. Supply currents in various operating modes.



**DC Voltage Measurement**

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 $\mu$ V , full range = -100...+300 mV  
Low Range: 1LSB = 61nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.903 $\pm$ 0.1% (k=2)	405.558 $\pm$ 0.1% (k=2)	404.679 $\pm$ 0.1% (k=2)
Low Range	3.95385 $\pm$ 0.7% (k=2)	3.97596 $\pm$ 0.7% (k=2)	3.92396 $\pm$ 0.7% (k=2)

**Connector Angle**

Connector Angle to be used in DASY system	11 $^{\circ}$ $\pm$ 1 $^{\circ}$
---	----------------------------------

**Appendix****1. DC Voltage Linearity**

High Range	Input ( $\mu\text{V}$ )	Reading ( $\mu\text{V}$ )	Error (%)
Channel X + Input	200000	200000.1	0.00
Channel X + Input	20000	20002.73	0.01
Channel X - Input	20000	-19994.94	-0.03
Channel Y + Input	200000	200000.4	0.00
Channel Y + Input	20000	19999.59	0.00
Channel Y - Input	20000	-19995.52	-0.02
Channel Z + Input	200000	200000.2	0.00
Channel Z + Input	20000	20000.11	0.00
Channel Z - Input	20000	-19998.59	-0.01

Low Range	Input ( $\mu\text{V}$ )	Reading ( $\mu\text{V}$ )	Error (%)
Channel X + Input	2000	2000	0.00
Channel X + Input	200	200.34	0.17
Channel X - Input	200	-200.17	0.08
Channel Y + Input	2000	2000.1	0.00
Channel Y + Input	200	199.33	-0.33
Channel Y - Input	200	-200.68	0.34
Channel Z + Input	2000	1999.9	0.00
Channel Z + Input	200	199.24	-0.38
Channel Z - Input	200	-201.01	0.50

**2. Common mode sensitivity**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading ( $\mu\text{V}$ )	Low Range Average Reading ( $\mu\text{V}$ )
Channel X	200	-13.88	-15.94
	- 200	16.64	16.19
Channel Y	200	-15.73	-16.74
	- 200	14.95	15.21
Channel Z	200	-8.70	-10.46
	- 200	8.55	8.69

**3. Channel separation**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X ( $\mu\text{V}$ )	Channel Y ( $\mu\text{V}$ )	Channel Z ( $\mu\text{V}$ )
Channel X	200	-	2.67	0.07
Channel Y	200	0.58	-	3.05
Channel Z	200	-1.84	0.66	-

**4. AD-Converter Values with inputs shorted**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16059	16215
Channel Y	15676	15942
Channel Z	15471	15731

**5. Input Offset Measurement**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M $\Omega$ 

	Average ( $\mu$ V)	min. Offset ( $\mu$ V)	max. Offset ( $\mu$ V)	Std. Deviation ( $\mu$ V)
Channel X	0.63	-1.23	2.00	0.38
Channel Y	-0.97	-2.83	0.94	0.46
Channel Z	-0.41	-2.34	0.55	0.40

**6. Input Offset Current**

Nominal Input circuitry offset current on all channels: &lt;25fA

**7. Input Resistance**

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.1999	198.3
Channel Y	0.2000	199.9
Channel Z	0.2000	199.7

**8. Low Battery Alarm Voltage** (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

**9. Power Consumption** (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9

**10. Common Mode Bit Generation** (verified during pre test)

Typical values	Bit set to High at Common Mode Error (V <sub>DC</sub> )
Channel X, Y, Z	+1.25